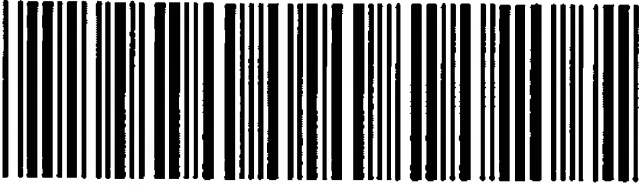


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/626,023	DEEVER, AARON T.	
	Examiner	Art Unit	
	Duy M. Dang	2624	

SEARCHED			
Class	Subclass	Date	Examiner
382	118 232 239 240	10/1/2006	DD
348	231.3	10/1/2006	DD

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East (uspto, derwent, jpo, epo, pgpub), see printout	10/1/2006	DD
Inventor search (east), see printout	10/1/2006	DD